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ATTY, DOCKET NO.	APPLICATION NO.		
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Bandini <i>et al.</i>	<u>:</u>		
FILING DATE		GROUP .	
June 22, 2001		2131	

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PTO/SB/08a/b (modified)

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App. No.	09/887,313
Filing Date	June 22, 2001
First Named Inventor	Jean-Christophe Bandini
Art Unit	2137
Examiner Name	Paul E. Calahan
Attorney Docket No.	TUMB-102CIP

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